

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10811739	OWENS ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Hung, Yubin	2624	

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	166, 236	6/9/08	YH
348	208.2, 208.6, 407.1, 413.1, 416.1	6/9/08	YH
375	240.1, 240.16	6/9/08	YH

<b>SEARCH NOTES</b>			
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>	
EAST Text searc (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)h	6/9/08	YH	
Inventor/Assignee search (EAST, eDAN)	6/9/08	YH	

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>